

# STE40NK90ZD

# N-channel 900V - 0.14Ω - 40A ISOTOP Super FREDmesh<sup>™</sup> MOSFET

#### **General features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	Pw
STE40NK90ZD	900V	<0.18Ω	40A	600W

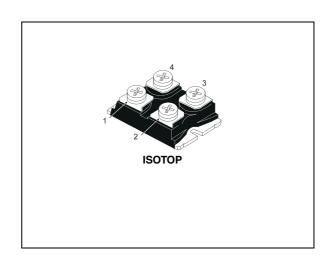
- Extremely high dv/dt capability
- 100% avalanche tested
- Very low intrinsic capacitances
- Very good manufacturing repeatibility

#### **Description**

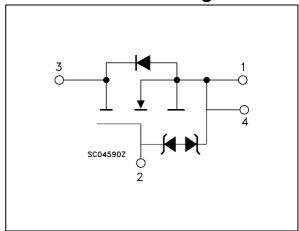
The SuperFREDMesh™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

## **Applications**

■ Switching application



#### Internal schematic diagram



#### **Order codes**

Part number	Marking	Package	Packaging
STE40NK90ZD	E40NK90ZD	ISOTOP	TUBE

Contents STE40NK90ZD

# **Contents**

1	Electrical ratings	3
2	Electrical characteristics	4
	2.1 Protection features of gate-to-source zener diodes	5
	2.2 Electrical characteristics (curves)	6
3	Test circuit	9
4	Package mechanical data 1	0
5	Revision history 1	2

STE40NK90ZD Electrical ratings

# 1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	900	٧
V <sub>DGR</sub>	Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )	900	V
V <sub>GS</sub>	Gate- source voltage	± 30	٧
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25°C	40	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100°C	25	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	160	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25°C	600	W
	Derating factor	5	W/°C
V <sub>ESD(G-S)</sub>	Gate source ESD(HBM-C=100pF, R=1.5KΩ)	7	KV
dv/dt (2)	Peak diode recovery voltage slope	8	V/ns
V <sub>ISO</sub>	Insulation withstand voltage (AC-RMS) from all four terminals to external heatsink	2500	٧
T <sub>j</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	- 65 to 150	°C

<sup>1.</sup> Pulse width limited by safe operating area

Table 2. Thermal data

Rthj-case	Thermal resistance junction-case max	0.2	°C/W
Rthj-amb	Thermal resistance junction-ambient max	40	°C/W

Table 3. Avalanche characteristics

Symbol	Parameter	Max. Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_j$ max)	40	А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 35$ V)	1.2	J

<sup>2.</sup>  $I_{SD} \leq 40A$ , di/dt  $\leq 500$  A/ $\mu$ s,  $V_{DD} \leq V_{(BR)DSS}$ 

Electrical characteristics STE40NK90ZD

## 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	900			٧
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	$V_{DS}$ = max rating $V_{DS}$ = max rating, $T_{C}$ = 125 °C			10 100	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20V			±10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$	2.5	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS} = 10V, I_D = 20A$		0.14	0.18	Ω

Table 5. Dynamic

	- j					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	V <sub>DS</sub> = 15V <sub>,</sub> I <sub>D</sub> = 20A		35		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25V, f = 1 \text{ MHz}, $ $V_{GS} = 0$		25000 1450 280		pF pF pF
C <sub>oss eq.</sub> (2)	Equivalent output capacitance	$V_{GS} = 0V$ , $V_{DS} = 0V$ to 720V		720		pF
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 450V, I_{D} = 18A$ $R_{G} = 4.7\Omega, V_{GS} = 10V$ (Figure 14)		92 102 450 200		ns ns ns ns
$egin{array}{c} Q_{ m g} \ Q_{ m gd} \end{array}$	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 720 \text{ V}, I_{D} = 36\text{A},$ $V_{GS} = 10\text{V}$		590 89 323	826	nC nC nC

<sup>1.</sup> Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5 %.

<sup>2.</sup>  $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

**Symbol Parameter Test conditions** Min. Typ. Max. Unit Source-drain current  $I_{SD}$ 40 Α I<sub>SDM</sub> (1) Source-drain current 160 Α (pulsed)  $V_{SD}^{(2)}$ ٧ Forward on voltage  $I_{SD} = 40A, V_{GS} = 0$ 1.6 Reverse recovery time  $I_{SD} = 36A$ , di/dt = 100A/ $\mu$ s 450  $t_{rr}$ ns μC  $V_{DD} = 50V, T_i = 25^{\circ}C$ Reverse recovery charge 3.6  $Q_{rr}$ (see Figure 16)  $I_{RRM}$ Reverse recovery current 16.2 Α  $I_{SD} = 36A$ , di/dt = 100A/ $\mu$ s Reverse recovery time 930  $t_{rr}$ ns Reverse recovery charge  $V_{DD} = 50V, T_i = 150^{\circ}C$ 12 μC  $Q_{rr}$ Reverse recovery current (see Figure 16) 26 Α  $I_{RRM}$ 

Table 6. Source drain diode

Table 7. Gate-source zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV <sub>GSO</sub>	Gate-source breakdown voltage	lgs=± 1mA (open drain)	30			٧

#### 2.1 Protection features of gate-to-source zener diodes

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

5/

<sup>1.</sup> Pulse width limited by safe operating area.

<sup>2.</sup> Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5 %.

Electrical characteristics STE40NK90ZD

#### 2.2 Electrical characteristics (curves)

Figure 1. Safe operating area

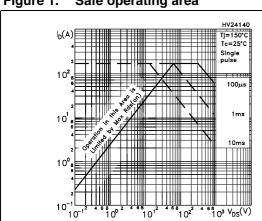


Figure 2. Thermal impedance

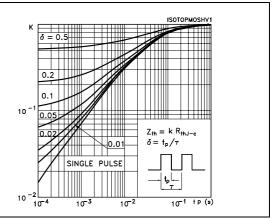


Figure 3. Output characterisics

Figure 4. Transfer characteristics

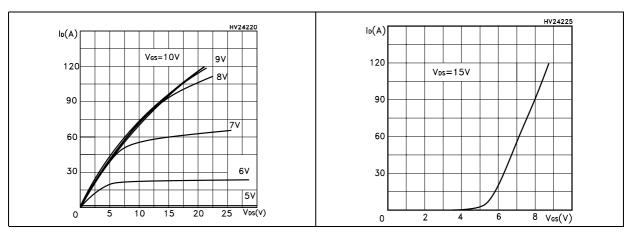
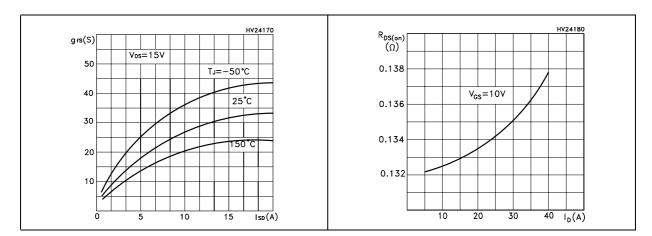


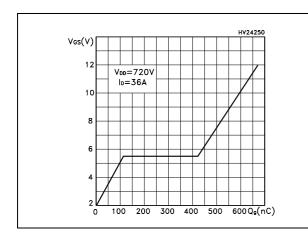
Figure 5. Transconductance

Figure 6. Static drain-source on resistance



6/13

Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations



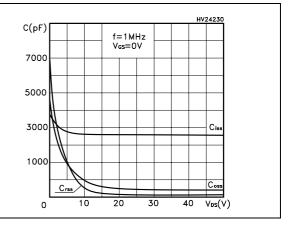
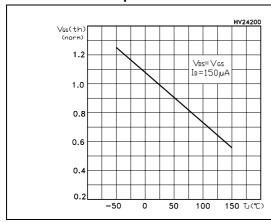


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature



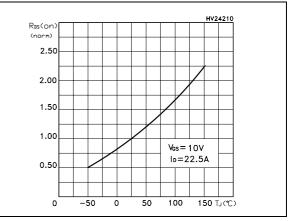
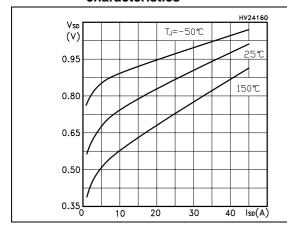
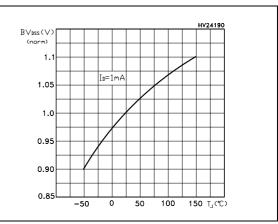


Figure 11. Source-drain diode forward characteristics

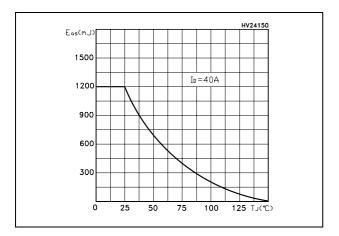
Figure 12. Normalized B<sub>VDSS</sub> vs temperature





Electrical characteristics STE40NK90ZD

Figure 13. Avalanche energy vs starting Tj



STE40NK90ZD Test circuit

## 3 Test circuit

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

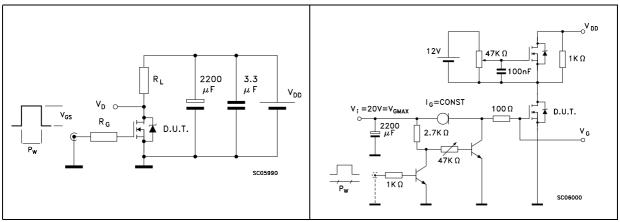


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped Inductive load test circuit

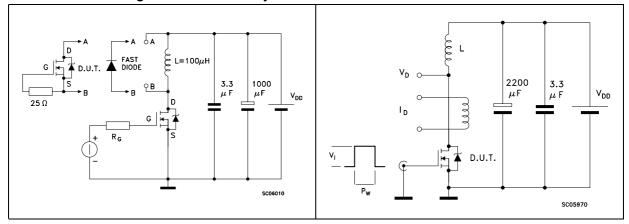
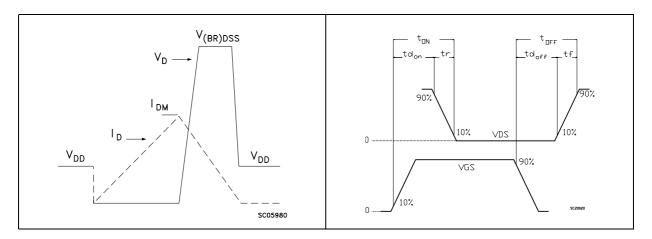


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



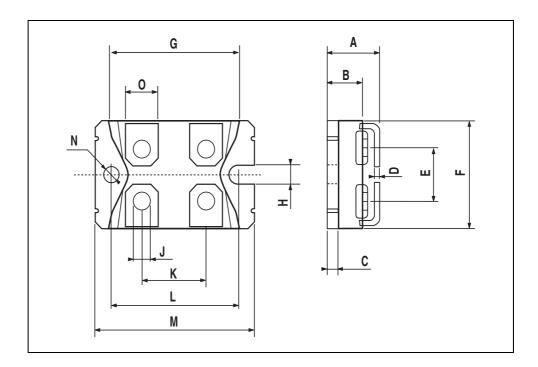
**577** 

# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

#### **ISOTOP MECHANICAL DATA**

DIM.	mm			inch		
Dilvi.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	11.8		12.2	0.466		0.480
В	8.9		9.1	0.350		0.358
С	1.95		2.05	0.076		0.080
D	0.75		0.85	0.029		0.033
E	12.6		12.8	0.496		0.503
F	25.15		25.5	0.990		1.003
G	31.5		31.7	1.240		1.248
Н	4			0.157		
J	4.1		4.3	0.161		0.169
K	14.9		15.1	0.586		0.594
L	30.1		30.3	1.185		1.193
М	37.8		38.2	1.488		1.503
N	4			0.157		
0	7.8		8.2	0.307		0.322



**47/** 

Revision history STE40NK90ZD

# 5 Revision history

Table 8. Revision history

Date	Revision	Changes	
24-May-2005	1	First Release	
10-Jun-2005	2	Inserted new row in Table 6.: Switching times	
28-Sep-2005	3	Complete version	
14-Oct-2005	4	Modified Figure 3, Figure 6	
12-Jul-2006	5	New template, no content change	

#### Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2006 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

